

COMPLIANT

2SK1456-VB Datasheet

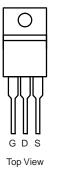
N-Channel 900V (D-S) Super Junction Power MOSFET

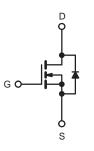
PRODUCT SUMMARY				
V _{DS} (V)	900			
R _{DS(on)} (Ω)	$V_{GS} = 10 V$	1.3		
Q _g (Max.) (nC)	200			
Q _{gs} (nC)	24			
Q _{gd} (nC)	110			
Configuration	Single			

FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- · Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC







N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T _C	= 25 °C, unl	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	900	V	
Gate-Source Voltage			V _{GS}	± 20	v	
Continuous Drain Current	V _{GS} at 10 V	T _C = 25 °C	- I _D	5		
Continuous Drain Current		T _C = 100 °C		3.9	A	
Pulsed Drain Current ^a			I _{DM}	21		
Linear Derating Factor				1.5	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	770	mJ	
Repetitive Avalanche Current ^a			I _{AR}	7.8	A	
Repetitive Avalanche Energy ^a			E _{AR}	19	mJ	
Maximum Power Dissipation $T_{C} = 25 \text{ °C}$			PD	190	W	
Peak Diode Recovery dV/dt ^c			dV/dt	2.0	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	- °C	
Soldering Recommendations (Peak Temperature) for 10 s		-	300 ^d			
Mounting Torque	6-32 or M3 screw			10	lbf ∙ in	
				1.1	N · m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD} = 50$ V, starting $T_J = 25$ °C, L = 23 mH, $R_g = 25 \Omega$, $I_{AS} = 7.8$ A (see fig. 12). c. $I_{SD} \le 7.8$ A, dl/dt ≤ 140 A/µs, $V_{DD} \le 600$ V, $T_J \le 150$ °C. d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply

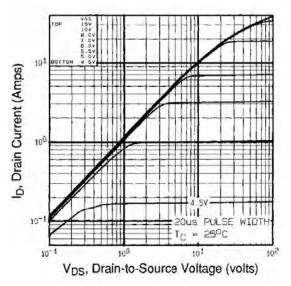
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THERMAL RESISTANCE RATI	NGS							
PARAMETER	SYMBOL	TYP.		MAX.			UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-		40		°C/W		
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.24		-				
Maximum Junction-to-Case (Drain)	R _{thJC}	-		0.65				
SPECIFICATIONS ($T_J = 25 \text{ °C}$, u		1						
PARAMETER	SYMBOL	TES	T CONDIT	IONS	MIN.	TYP.	MAX.	UNIT
Static		Т				1		
Drain-Source Breakdown Voltage	V _{DS}		= 0 V, I _D =		900	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$		e to 25 °C,		-	0.98	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	$= V_{GS}, I_D =$	250 µA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}		$V_{GS} = \pm 20$		-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	-	= 800 V, V _G	-	-	-	100	μA
	-033	V _{DS} = 640 \	/, V _{GS} = 0 \	/, T _J = 125 °C	-	-	500	P. 1
Drain-Source On-State Resistance	R _{DS(on)}	$V_{GS} = 10 V$	ار	₀ = 3.7 A ^b	-	1.3	-	Ω
Forward Transconductance	g fs	V _{DS} =	= 100 V, I _D =	= 3.7 A ^b	5.6	-	-	S
Dynamic								
Input Capacitance	C _{iss}		V _{GS} = 0 V	1	-	3100	-	
Output Capacitance	C _{oss}	$V_{DS} = 25 V,$		-	800	-	pF	
Reverse Transfer Capacitance	C _{rss}	f = 1	f = 1.0 MHz, see fig. 5		-	490	-	
Total Gate Charge	Qg				-	-	200	
Gate-Source Charge	Q _{gs}	$V_{GS} = 10 V$ $I_D = 3.8 A, V_{DS} = 400 V,$			-	-	24	nC
Gate-Drain Charge	Q _{gd}		see fig. 6 and 13 ^b		-	-	110	
Turn-On Delay Time	t _{d(on)}				-	19	-	
Rise Time	t _r	V _{DD} =	= 400 V, I _D	= 3.8 A,	-	38	-	
Turn-Off Delay Time	t _{d(off)}	$V_{DD} = 400 \text{ V, } I_D = 3.8 \text{ A,} \\ R_g = 6.2 \Omega, R_D = 52 \Omega \\ \text{see fig. } 10^b$		-	120	-	ns	
Fall Time	t _f			-	39	-		
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	5.0	-	nH	
Internal Source Inductance	L _S			-	13	-		
Drain-Source Body Diode Characteristic	S							
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	5.0	•	
Pulsed Diode Forward Current ^a	I _{SM}			-	-	21	A	
Body Diode Voltage	V _{SD}	$T_{J} = 25 \text{ °C}, I_{S} = 3.8 \text{ A}, V_{GS} = 0 \text{ V}^{b}$		-	-	1.8	V	
Body Diode Reverse Recovery Time	t _{rr}	Т. =	25 °C. I⊧ =	3.8 A.	-	650	980	ns
Body Diode Reverse Recovery Charge	Q _{rr}	T_J = 25 °C, I _F = 3.8 A, dl/dt = 100 A/μs ^b		-	3.8	5.7	μC	
Forward Turn-On Time	t _{on}	Intrinsic tu	rn-on time	is negligible (turn	-on is do			

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Pulse width ≤ 300 µs; duty cycle ≤ 2 %.





TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



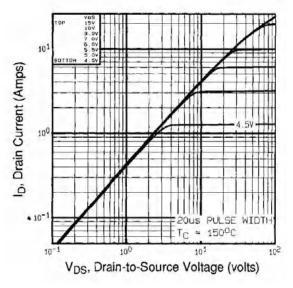


Fig. 2 - Typical Output Characteristics, $T_C = 150$ °C

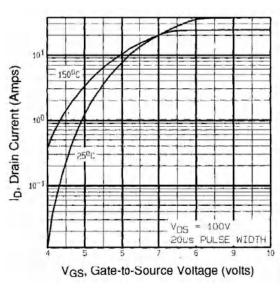


Fig. 3 - Typical Transfer Characteristics

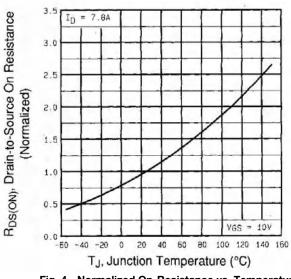


Fig. 4 - Normalized On-Resistance vs. Temperature



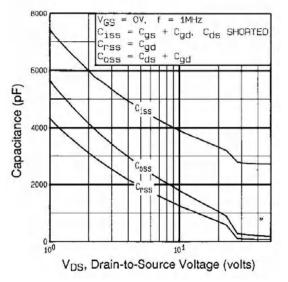


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage



Fig. 7 - Typical Source-Drain Diode Forward Voltage

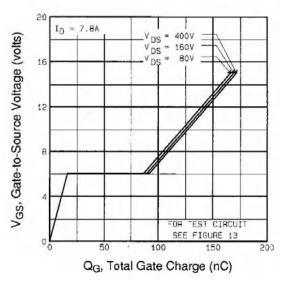
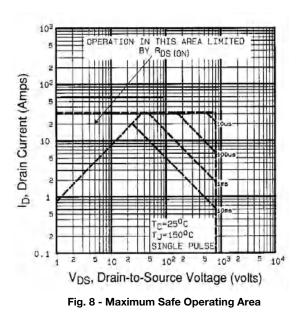


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



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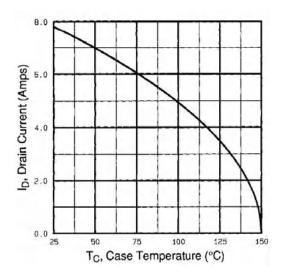


Fig. 9 - Maximum Drain Current vs. Case Temperature

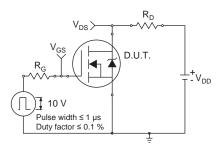


Fig. 10a - Switching Time Test Circuit



Fig. 10b - Switching Time Waveforms

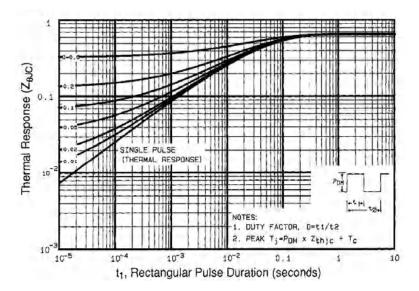


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



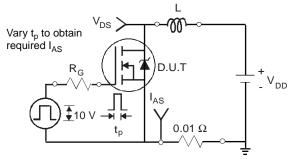


Fig. 12a - Unclamped Inductive Test Circuit

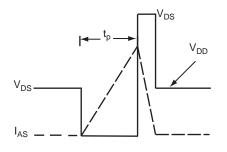


Fig. 12b - Unclamped Inductive Waveforms

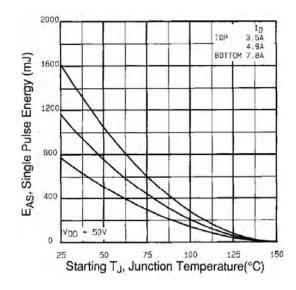


Fig. 12c - Maximum Avalanche Energy vs. Drain Current



Fig. 13a - Basic Gate Charge Waveform

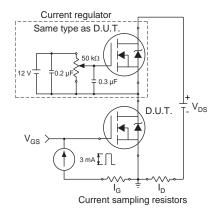
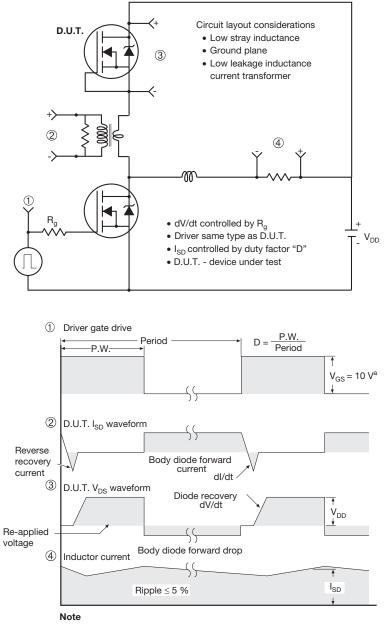


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

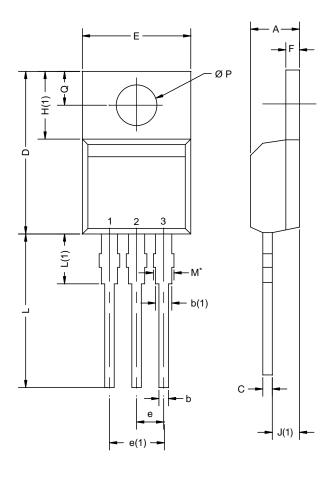


a. $V_{GS} = 5 V$ for logic level devices

Fig. 14 - For N-Channel



TO-220AB



	MILLIN	IETERS	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
А	4.25	4.65	0.167	0.183	
b	0.69	1.01	0.027	0.040	
b(1)	1.20	1.73	0.047	0.068	
С	0.36	0.61	0.014	0.024	
D	14.85	15.49	0.585	0.610	
Е	10.04	10.51	0.395	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.09	6.48	0.240	0.255	
J(1)	2.41	2.92	0.095	0.115	
L	13.35	14.02	0.526	0.552	
L(1)	3.32	3.82	0.131	0.150	
ØР	3.54	3.94	0.139	0.155	
Q	2.60	3.00	0.102	0.118	
ECN: X12- DWG: 547	0208-Rev. N, 1	08-Oct-12			

Notes

* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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